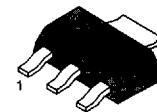


# IRFM014/10

## FEATURES

- Lower  $R_{DS(on)}$
- Improved inductive ruggedness
- Fast switching times
- Rugged polysilicon gate cell structure
- Lower input capacitance
- Extended safe operating area
- Improved high temperature reliability

SOT-223



1. Gate 2. Drain 3. Source

## PRODUCT SUMMARY

Part Number	BVoss	$R_{DS(on)}$	$I_D$
IRFM014	60V	0.2Ω	2.7A
IRFM010	50V	0.2Ω	2.7A

## ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	IRFM014	IRFM010	Unit
Drain-Source Voltage (1)	$V_{DSS}$	60	50	Vdc
Drain-Gate Voltage ( $R_{GS}=1.0M\Omega$ ) (1)	$V_{DGR}$	60	50	Vdc
Gate-Source Voltage	$V_{GS}$	$\pm 20$		Vdc
Continuous Drain Current $T_c=25^\circ C$	$I_D$	2.7	2.7	Adc
Continuous Drain Current $T_c=100^\circ C$	$I_D$	1.7	1.7	Adc
Drain Current - Pulsed (3)	$I_{DM}$	22	22	Adc
Single Pulsed Avalanche Energy (4)	$E_{AS}$	100	100	mJ
Avalanche Current	$I_{AS}$	2.7	2.7	A
Total Power Dissipation at $T_c=25^\circ C$	$P_D$	3.125	3.125	Watts
Derate above $25^\circ C$		0.025	0.025	$W/^\circ C$
Operating and Storage Junction Temperature Range	$T_J, T_{STG}$	-55 to +150		°C
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	$T_L$	300		°C

Notes : (1)  $T_J=25^\circ C$  to  $150^\circ C$

(2) Pulse test : Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$

(3) Repetitive rating : Pulse width limited by junction temperature

(4)  $L=16mH$ ,  $V_{DD}=25V$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ C$

**ELECTRICAL CHARACTERISTICS** ( $T_c=25^\circ C$  unless otherwise specified)

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
BV <sub>dss</sub>	Drain-Source Breakdown Voltage				V	$V_{GS}=0V$ , $I_D=250\mu A$
	IRFM014	60	-	-	V	
	IRFM010	50	-	-	V	
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	-	4.0	V	$V_{DS}=V_{GS}$ , $I_D=250\mu A$
I <sub>GS</sub>	Gate-Source Leakage Forward	-	-	100	nA	$V_{GS}=20V$
I <sub>GR</sub>	Gate-Source Leakage Reverse	-	-	-100	nA	$V_{GS}=-20V$
I <sub>DS</sub>	Zero Gate Voltage Drain Current	-	-	250	$\mu A$	$V_{DS}=\text{Max. Rating}$ , $V_{GS}=0V$
		-	-	1000	$\mu A$	$V_{DS}=0.8 \text{ Max. Rating}$ , $V_{GS}=0V$ , $T_c=150^\circ C$
R <sub>DS(on)</sub>	Static Drain-Source On Resistance(2)	-	-	0.2	$\Omega$	$V_{GS}=10V$ , $I_D=1.4A$
g <sub>fs</sub>	Forward Transconductance (2)	1.9	-	-	$\Omega$	$V_{DS}=25V$ , $I_D=1.4A$
C <sub>iss</sub>	Input Capacitance	-	300	-	pF	
C <sub>oss</sub>	Output Capacitance	-	160	-	pF	$V_{GS}=0V$ , $V_{DS}=25V$ , $f=1MHz$
C <sub>rss</sub>	Reverse Transfer Capacitance	-	29	-	pF	
t <sub>d(on)</sub>	Turn-On Delay Time	-	10	-	ns	$V_{DD}=0.5 BV_{dss}$ , $I_D=2.7A$ , $Z_0=24\Omega$ (MOSFET switching times are essentially independent of operating temperature)
t <sub>r</sub>	Rise Time	-	50	-	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	-	13	-	ns	
t <sub>f</sub>	Fall Time	-	19	-	ns	
Q <sub>g</sub>	Total Gate Charge (Gate-Source Plus Gate-Drain)	-	-	11	nC	$V_{GS}=10V$ , $I_D=2.7A$ , $V_{DS}=0.8 \text{ Max. Rating}$ (Gate charge is essentially independent of operating temperature)
Q <sub>gs</sub>	Gate-Source Charge	-	3.1	-	nC	
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge	-	5.8	-	nC	

**THERMAL RESISTANCE**

Symbol	Characteristics		IRFM014	Units	Remark
R <sub>thJC</sub>	Junction-to-case	MAX	40	K/W	
R <sub>thJA</sub>	Junction-to-Ambient	MAX	60	K/W	Free Air Operation

Notes : (1)  $T_J=25^\circ C$  to  $150^\circ C$

(2) Pulse test : Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$

(3) Repetitive rating : Pulse width limited by max. junction temperature

## SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
I <sub>s</sub>	Continuous Source Current (Body Diode)	-	-	2.7	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier
I <sub>SM</sub>	Pulse Source Current (Body Diode) (3)	-	-	22	A	
V <sub>SD</sub>	Diode Forward Voltage (2)	-	-	1.6	V	T <sub>J</sub> =25°C, I <sub>s</sub> =2.7A, V <sub>GS</sub> =0V
t <sub>r</sub>	Reverse Recovery Time	-	70	140	ns	T <sub>J</sub> =25°C, I <sub>F</sub> =2.7A, dI/dt=100A/μS

Notes : (1) T<sub>J</sub>=25°C to 150°C

(2) Pulse test : Pulse width ≤ 300 μs, Duty Cycle ≤ 2%

(3) Repetitive rating : Pulse width limited by max. junction temperature

